

An EBIS-based RHIC Preinjector

Test EBIS Results

Ed Beebe

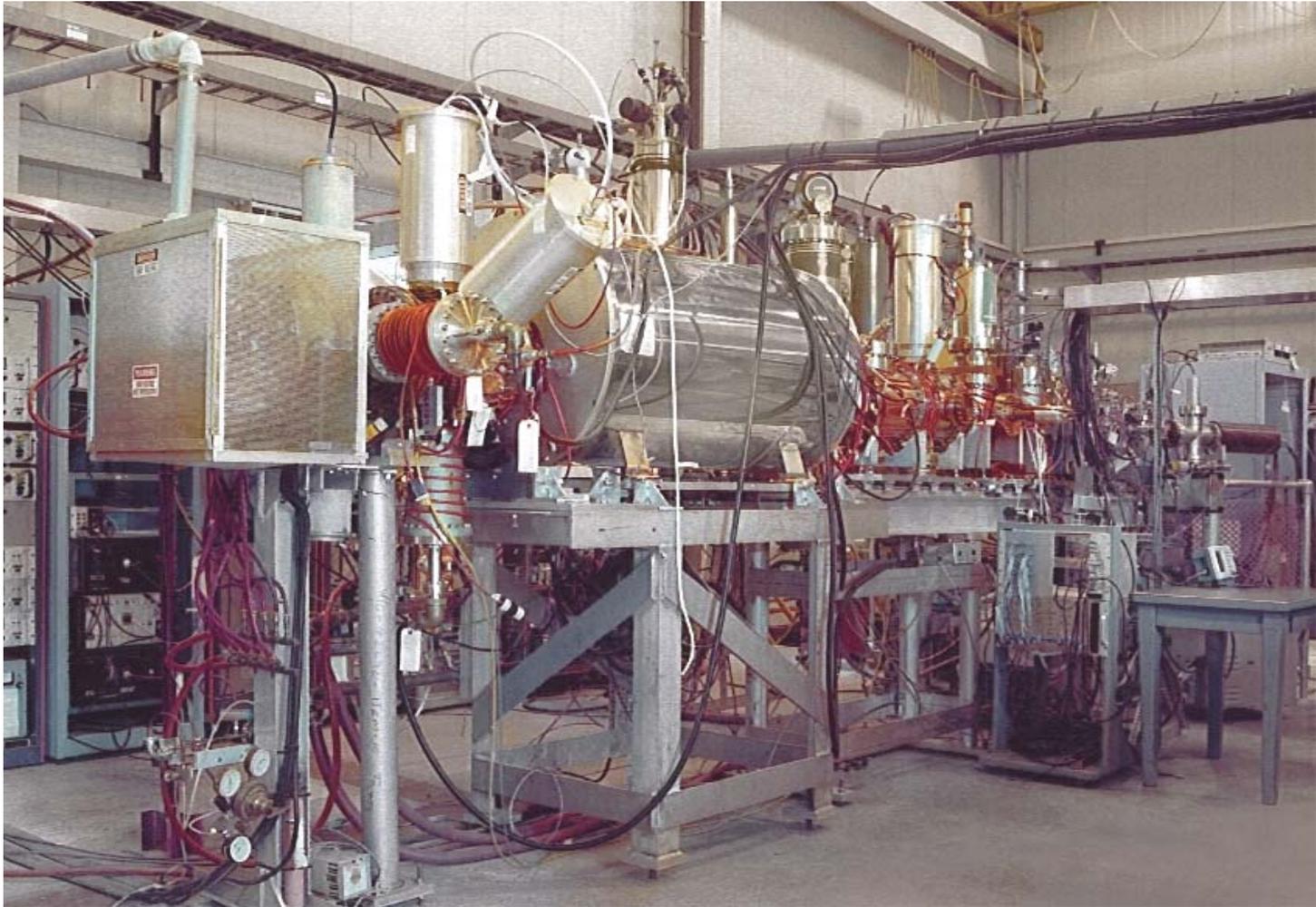
Preinjector Group
Collider-Accelerator Department

Linac-based Preinjector - Source “requirements”

1. Intensity for 1×10^9 Au ions/bunch in RHIC : $\sim 3 \times 10^9$ Au³²⁺ ions/pulse
from the source
2. No stripping before Booster injection : $q/m > 0.16$ (Au³²⁺, Si¹⁴⁺, Fe²¹⁺)
3. 1-4 turn injection into Booster : pulse width 10-40 μ s

(Note - 1 & 3 result in a Au³²⁺ current of 1.6 - 0.4 mA)
4. Rep rate : ~ 5 Hz
5. Emittance : $\leq 0.35 \pi$ mm mrad, normalized, 90%
(for low loss at Booster injection)

EBIS Test Stand



EBIS Test Stand - ~1/2 length prototype, but with the full 10A electron beam

Key hardware features of the Test EBIS

Superconducting solenoid:	
Length	1 meter
Maximum field	5 Tesla
Bore	155 mm diameter, warm
Helium consumption	0.12 l/hr
Drift tubes:	
No. of electrodes	12
Bore diameter	31 mm
Trap length	0.7 m
Electron gun cathode	LaB₆, 8.3 mm diameter
Electron collector power	50 kW
Vacuum	1 x 10⁻⁹ to 4 x 10⁻¹⁰ Torr in most regions (most sections bakeable to 200C, central DT's to 450 C)
Diagnostics:	
Time-of-flight	Mamyrin-type, 2 m from ion extractor
Current meas.	0.5 and 1.5 m from ion extractor
Harp	1.6 m from ion extractor
Emittance	1.6 m from ion extractor (under development)

Some Principles for a Reliable, Low Maintenance EBIS

The basic principle that has been followed is to separate the functions of source components and remove as much of the action as possible from the high vacuum ionization region.

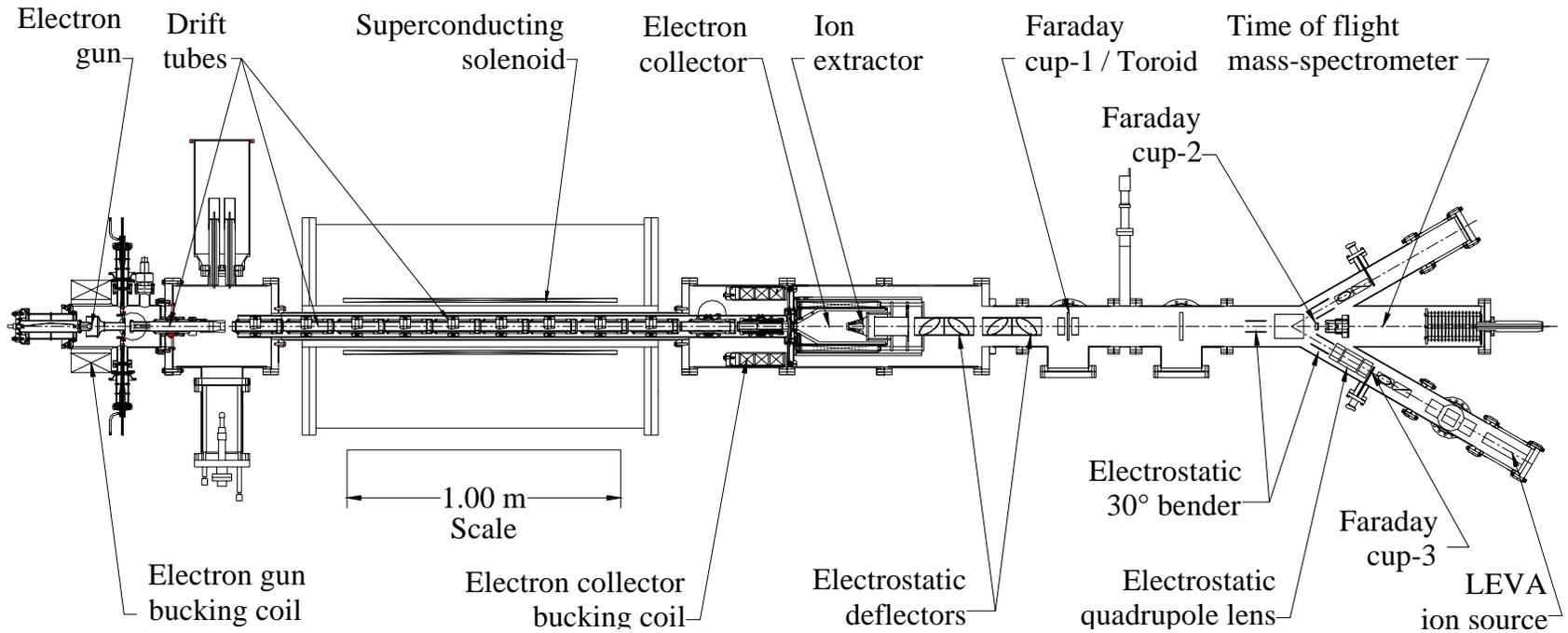
Provide beam current loss monitoring on all elements in beam path

Avoid magnetic shims and shields where possible; allow for external corrections or reshaping of magnetic geometry

External ion injection:

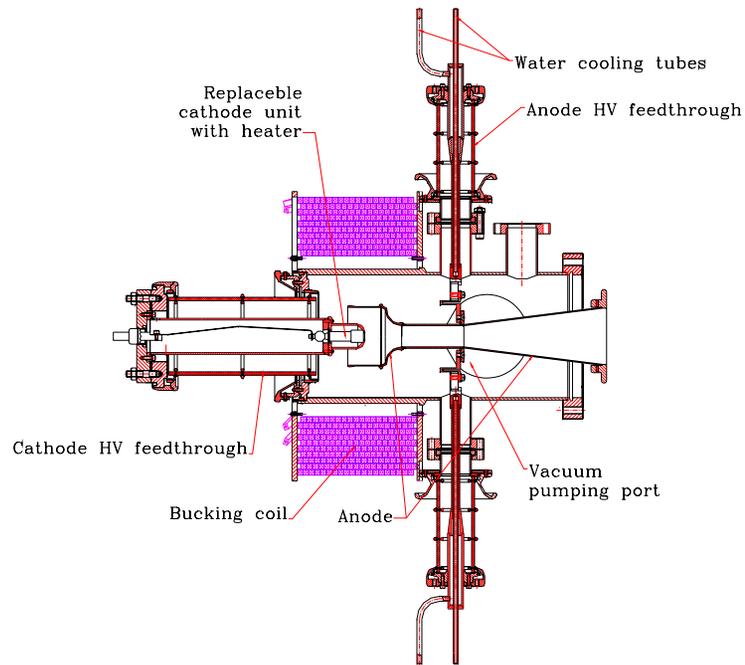
EBIS acts as a charge state multiplier, low contamination, high reliability

Test EBIS - showing ion injection, and extraction to TOF

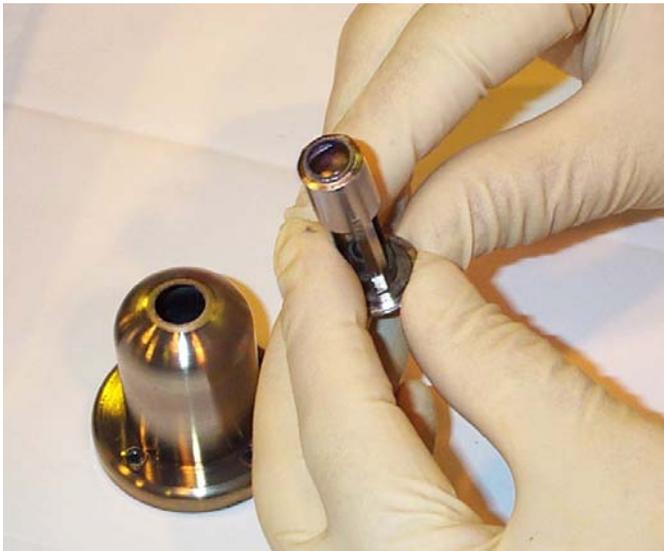


BNL Test EBIS performance represents *more than an order of magnitude improvement* over past EBIS sources. At the same time, operation has been very reproducible and stable. Some of the key features, almost all of which are unique to this EBIS, are the following:

- A **novel electron gun design** from Novosibirsk. It uses a convex LaB₆ cathode
- A **warm bore, unshielded superconducting solenoid** for the main trap region
- Careful **vacuum separation of the trap region** from the electron gun and electron collector regions
- **Large bore (32mm) drift tubes** have been used (pumping, reduced alignment precision, fast extraction, reduced RF coupling)
- The use of auxiliary (warm) solenoids & many **transverse magnet coils** for steering corrections
- The **electron beam is pulsed** to reduce the average power on the electron collector
- Very **versatile controls** allow one to easily apply a time dependent potential distribution to the ion trap

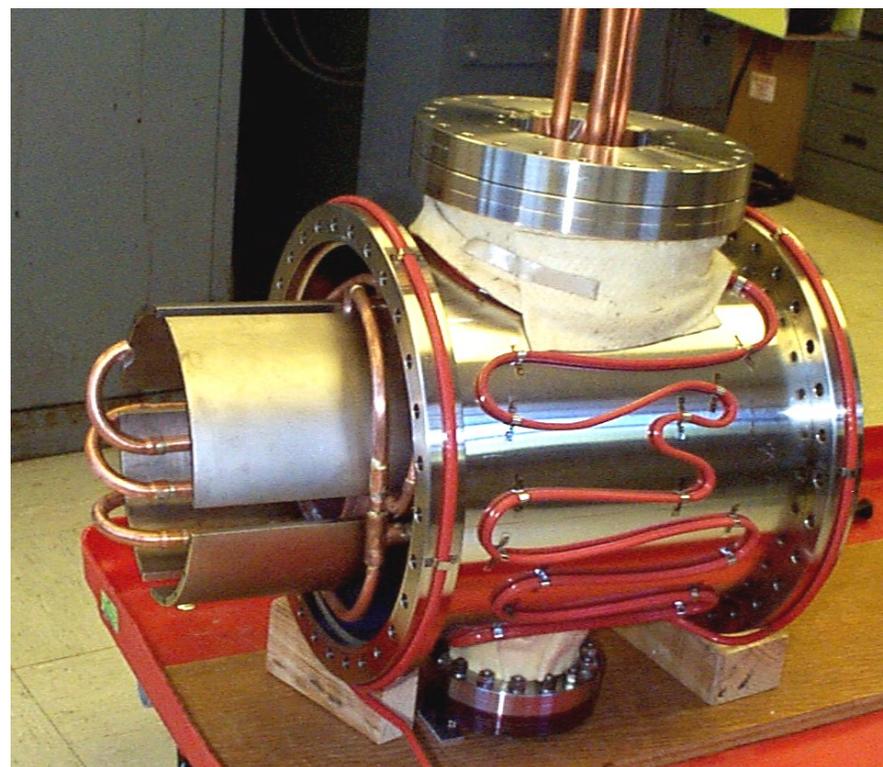
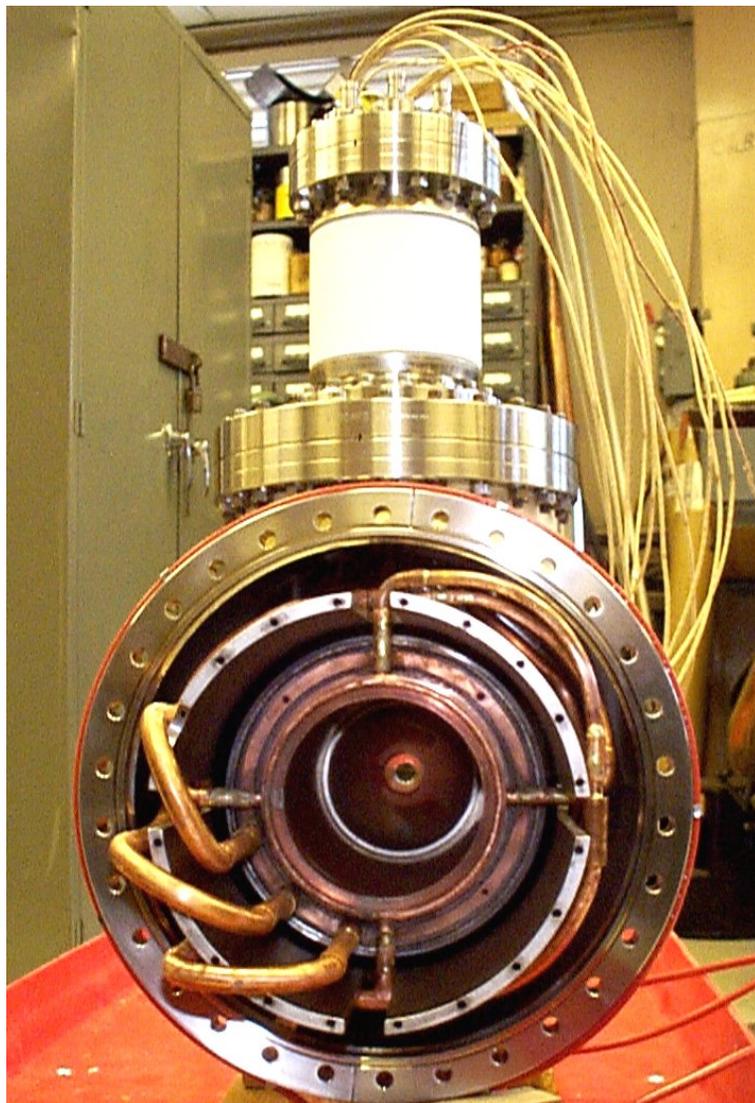


Electron Gun Cathode Assembly



E. Beebe
Test EBIS Results

Machine Advisory Committee
3/10/04



Electron Collector Assembly



Drift tube electrode assembly

Low Energy Vacuum Arc Ion source



Low charge state Au ions are injected into the EBIS from this source

E. Beebe
Test EBIS Results

Hollow Cathode Ion Source



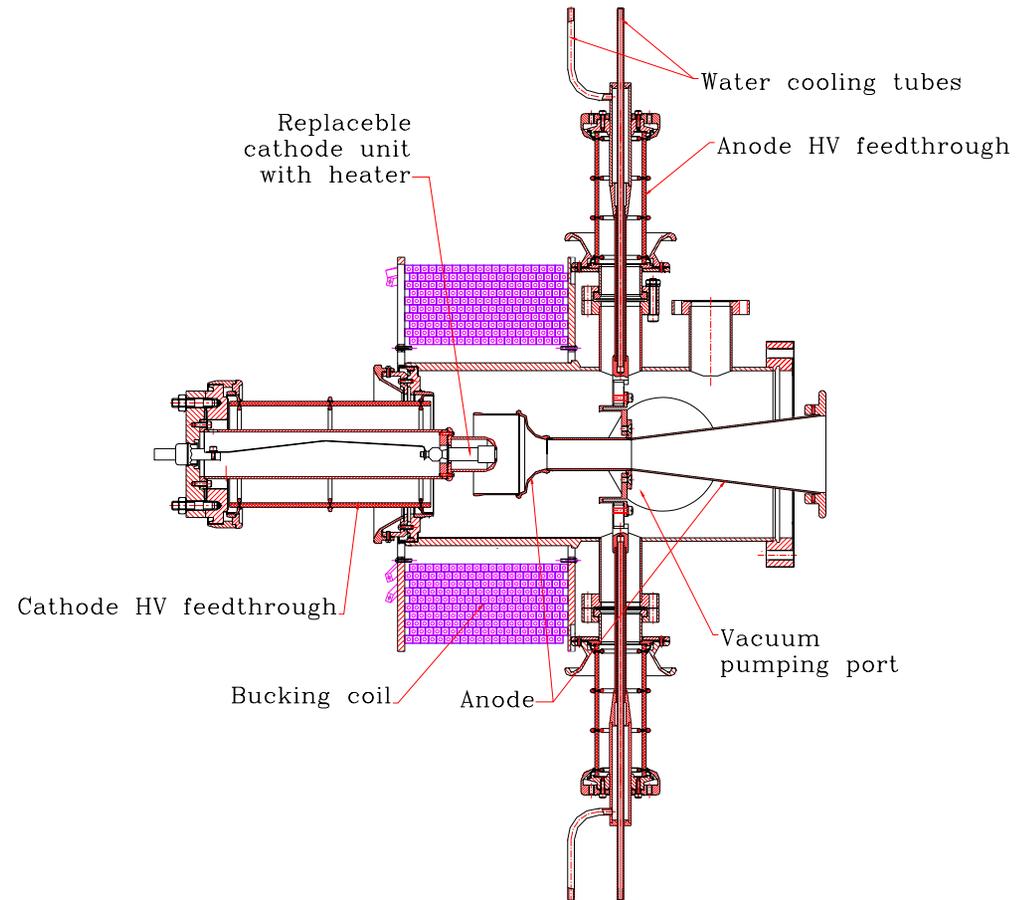
A variety of low charge state gaseous and metal ions can be produced in this ion source which has been obtained from Saclay and bench tested at BNL

Machine Advisory Committee
3/10/04

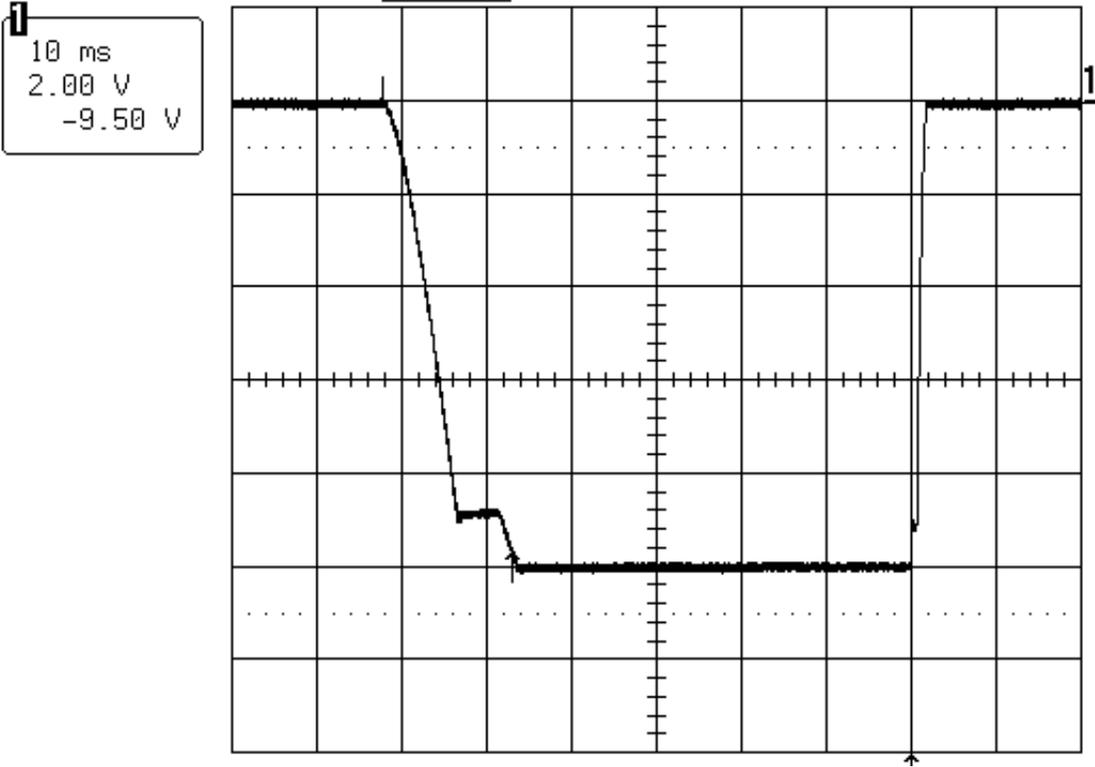
Development of the 10A electron Gun

This was a key element, since previous EBIS operation was typically at 0.5A or less

- Collaboration with BINP on the development of a LaB6 – based electron gun.
- This gun has produced currents of up to 13A, has a good lifetime, and excellent beam optics.
- The unique optics for extraction and matching into the strong magnetic field allows a very stable operation over a broad range of electron beam currents.



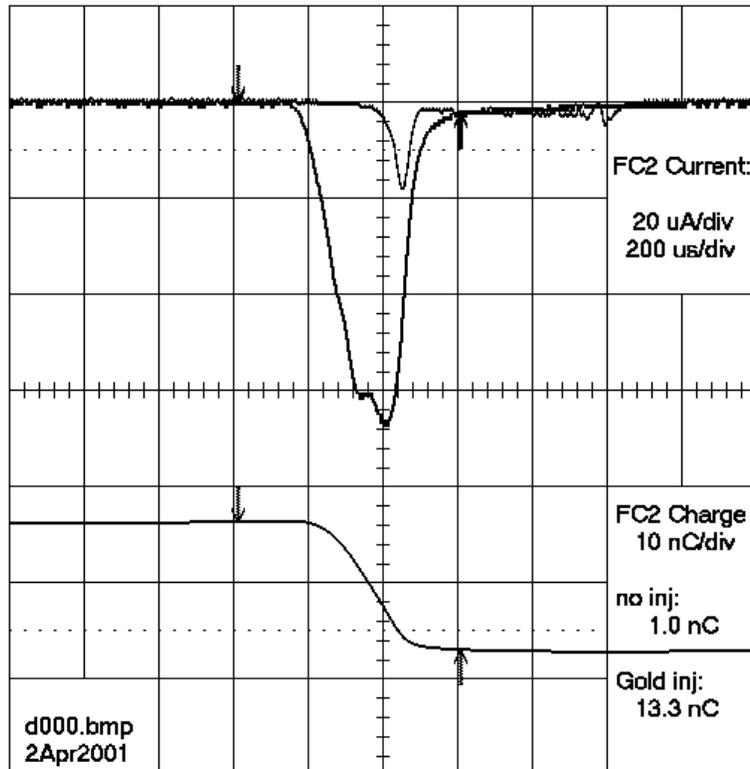
Propagation of a 10A electron beam through the BNL Test EBIS



The electron beam current faithfully responds to the ramping commands issued by the control system as illustrated by the 10A, 50ms electron beam pulse above.

Gold Injection from the LEVA auxiliary ion source

External ion injection allows various ion species to be introduced into the EBIS in a precise and rapid manner. This allows the EBIS to produce a high purity beam highly charged ions of the injected species.

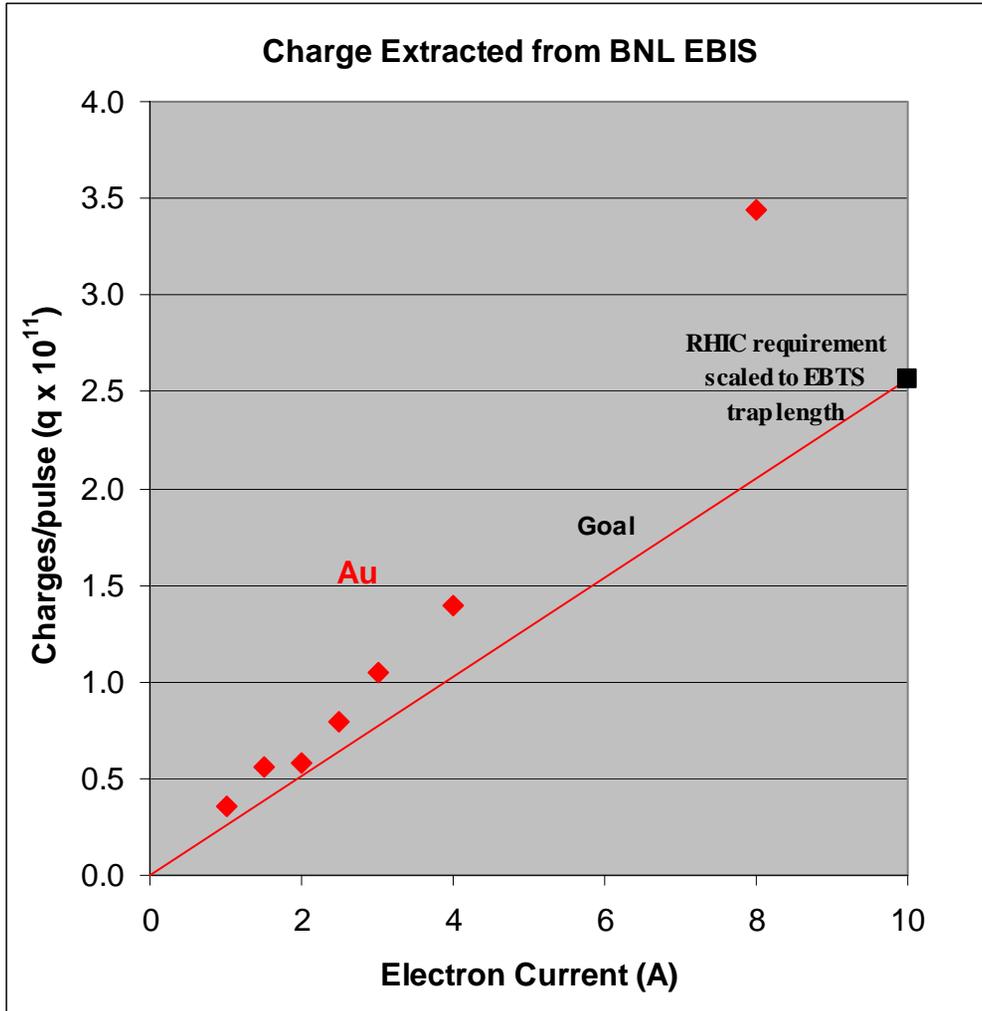


The upper traces show EBIS extracted ion current measured on a Faraday cup with and without Au injection and 200 μ s capture time.

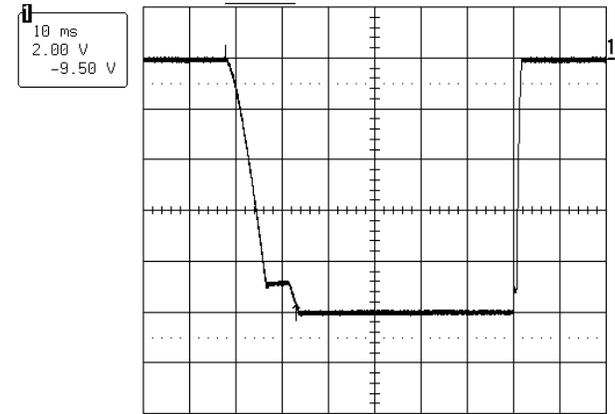
The lower trace shows the total charge extracted from EBIS 2ms after the Au injection.

($I_e = 4A$, $T_{inj} \sim 200 \mu s$, $T_c = 2ms$)

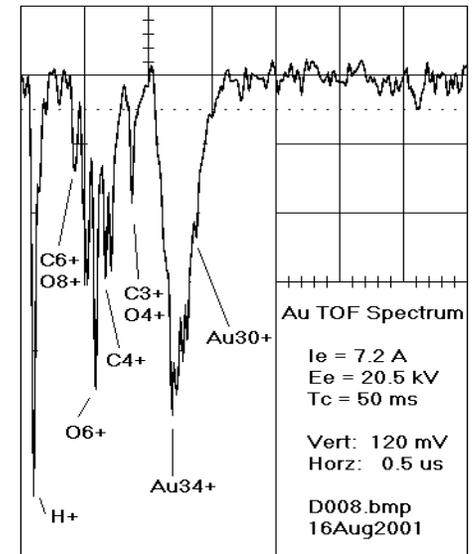
Results from Test EBIS (1/2 Length of RHIC EBIS)



5.5×10^{11} charges/pulse are required for RHIC. By doubling the EBIS trap length to 1.5 m, we will exceed this requirement. (The ion yield has been shown to scale linearly with trap length).



10 A, 50 ms Electron Beam Pulse

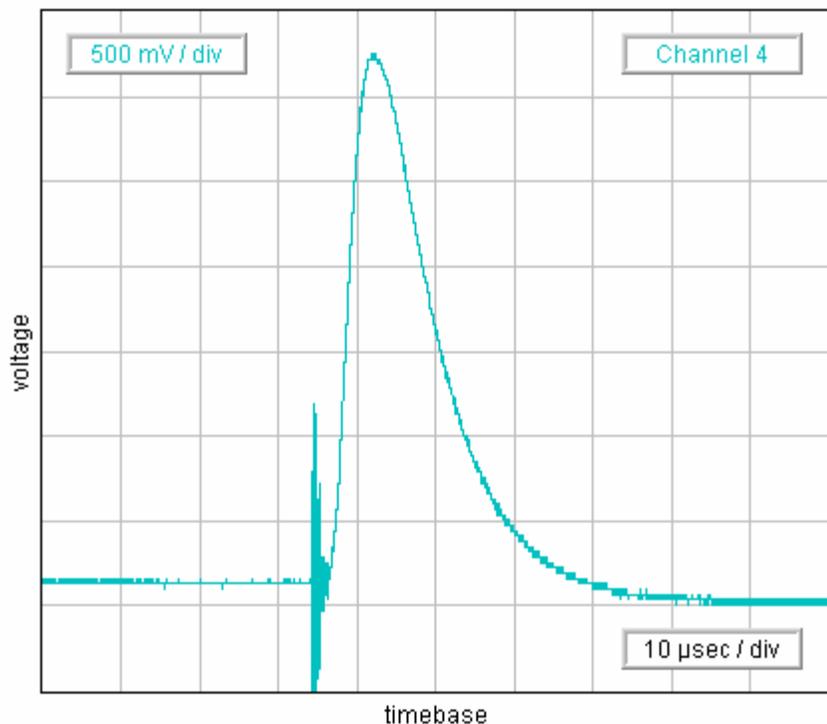


Time-of-flight spectrum peaked at Au 34+

Fast Extraction of Ions from the EBTS

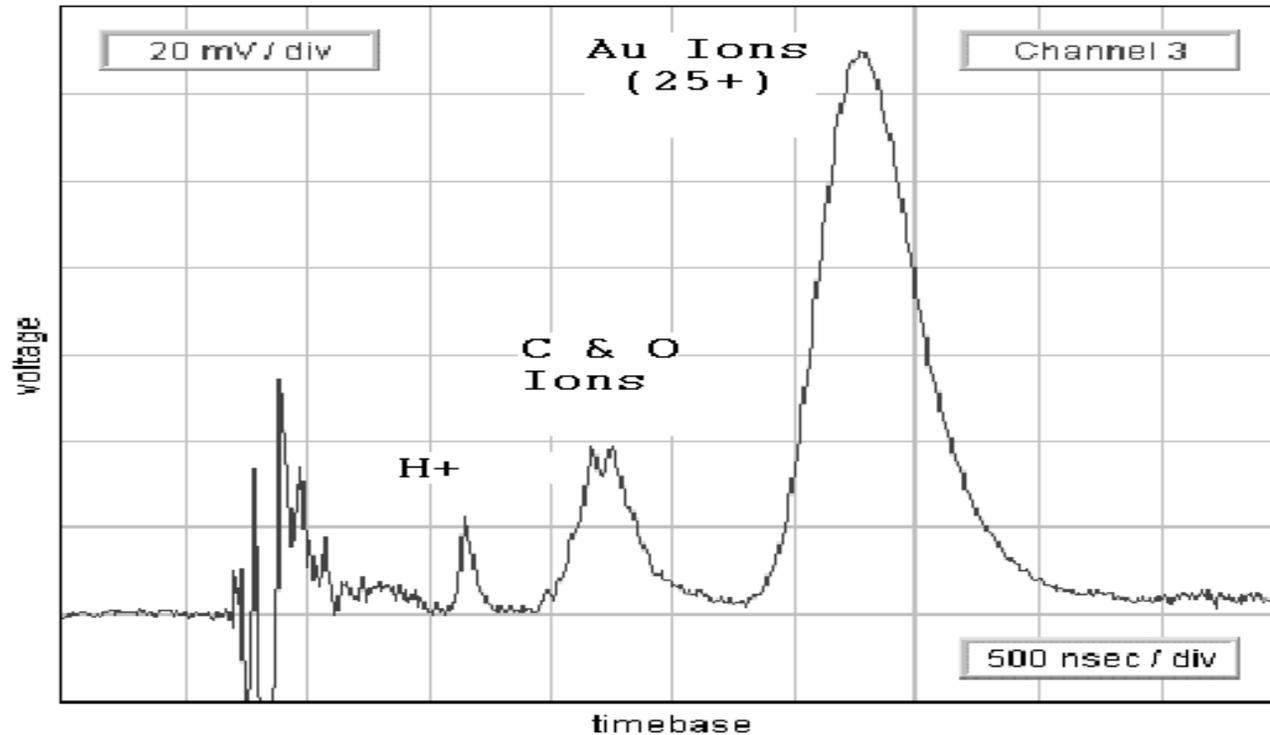
(for single turn injection into Booster)

A 3.2mA, 12 μ s FWHM, (40nC) ion pulse was obtained at the source exit toroid using a 6.8A e-beam and Au external ion injection, after a 15ms confinement. (85 nC required for RHIC)



Faster extraction has been obtained earlier by applying a gradient to the well floor during extraction. In the future, the pulse shape will be tailored by applying an appropriate voltage pulse to the well.

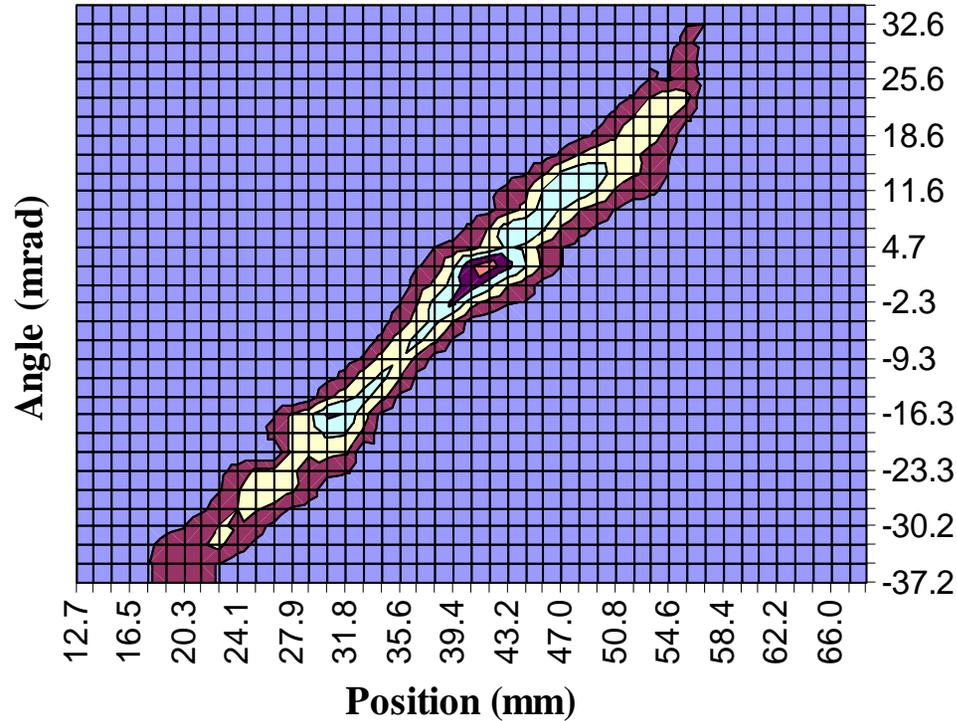
Inline Time-of-Flight



- A 100 ns sample of EBIS total extracted ion current pulse was made and measured on a Faraday Cup about 1.5 m downstream.
- The fraction of charge in Au was greater than 80%.

$I_e = 7\text{A}$; $T_c = 10\text{ ms}$; Au = 83%; C&O = 15%; H = 2%

Emittance



Emittance of a 1.7 mA extracted beam from EBIS,
with Au injection. ϵ (n, rms) = 0.1π mm mrad.

EBIS Voltage and Timing Controller

The controller coordinates the application of all time dependent voltages and timing references associated with EBIS operation with a time resolution of 1 μs , such as:

- Time dependent ion trap HV
- Electron beam ramping
- Table Driven Beamline Optics for Ion injection from Multiple sources and EBIS ion beam extraction

Screen for controlling EBIS electrode voltages during a cycle

EBIS TIMING & VOLTAGE CONTROL (Version 2.64)

Version 2.64
31 May 2003

	Chan.1 entr sol 0-30 kV	Chan.2 DT 1,2 0-20 kV	Chan.3 DT 3,4 0-30 kV	Chan.4 DT 5,6,7,8 0-20 kV	Chan.5 DT 9 0-20 kV	Chan.9 Blke DT9 0-15 kV	Chan.7 DT 10, 11 0-10 kV	Chan.8 DT12 0-10 kV	Chan.10 Coll. Coil 0-10 kV	Chan.11 Gun T mag 0-3 kV	Chan.12 chopper 0-20 kV	Chan.6 EG Anode 0-40 kV	Duration Time 1-3145680 μ s	Ramp Time 0-65535 μ s
1.Subcycle	21500	0	0	0	0	4600	0	0	9500	0	165	0	600000	4000
2.Subcycle	21500	13100	12500	8000	9800	4600	5000	3500	9500	1700	165	0	300	3500
setup	21500	13100	12500	13480	9800	4600	7000	3500	9500	1700	165	0	1000	1300
inj start	21500	13100	12500	10480	9800	4600	7000	3500	9500	1700	165	0	1100	300
inj finish	21500	13100	12500	9000	9000	4600	7000	3500	9500	1700	165	37200	920	310
conf1	21500	13100	12500	9000	10000	4600	7000	3500	9500	1700	15000	37200	50	810
conf2	21500	13100	12500	9000	10000	4600	7000	3500	9500	1700	15000	37200	20000	500
Extraction	21500	13100	12500	12000	10000	4600	7000	3500	9500	1700	15000	0	500	1000
Cleaning	21500	13100	12500	12000	10000	4600	5000	3500	9500	1700	165	0	1000	5500
Idle	21500	0	0	0	0	4600	0	0	9500	0	165	0	800000	65535

Cycle Editor:

Timing Panels: Instant Voltage Execution
Keep mem. page on HV change

Configure Edit Pulses Insert Line Edit Optics Delete Line Edit Ramps

Supercycle Manager:

Display Cycle Selector: Cycle 1 (Enabled), Cycle 2 (Disabled), Cycle 3 (Disabled)

Execution: Repeat: Total Period (sec): 1 1.507625

Color Links:

Red Group: Navy
Blue Group: Blue
Black Group: Charcoal
Green Group: None

Frequency Correction:

Cycle Period (sec): 1.507625
Cycle Freq. (Hz): 0.663295
Apply to Subcycle: Idle
Synt. Frequency: 60.0000
Line Frequency: 60.0000

Data Management:

File Date & Comment: 09/18/2003 2
Last Loaded File: c:\MeasurementStudio\EbisVer2.64\030918-02_7Amps23ms.prl
Last Saved File: None

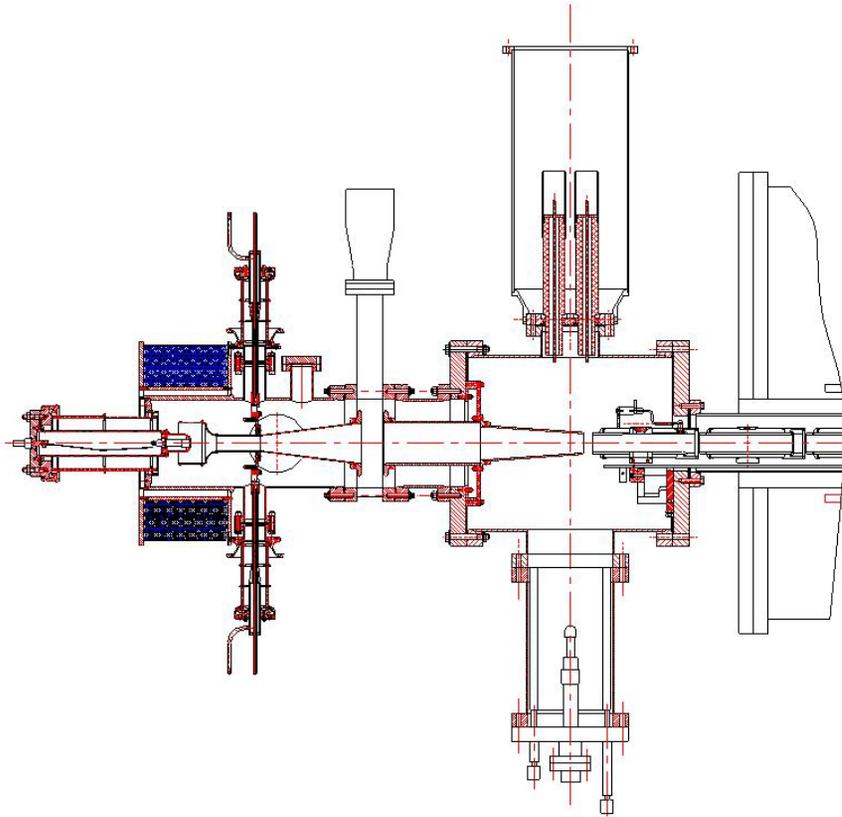
Hardware Control:

Execute COM Port (Not transmitting, Not executing)
Shut All HV Transmit
Shut El. Gun DDE Connect
Reset TCP Connect

Panel Color: Orange System
Diagnostics: On Off
Oscilloscope
Diag. Page
Signal Freq.

- The EBIS highly charged ion beam species and charge state can be selected on a pulse to pulse basis.
- 16 independent beamline optics tables for fast switching between devices.

IrCe Gun, Gate Valve, and Anode Modification



- IrCe Cathodes have been delivered from BINP, Novosibirsk. Electron beams up to 10A, 100kW have been propagated with very low loss.
- Cathode replacement and electron gun upgrades without disturbing ionization volume ultra-high vacuum.
- Anode/Drift Tube geometry eliminates need for an additional auxiliary solenoid

EBIS Status

	Achieved	RHIC
Ion	Au ³²⁺	Au ³²⁺
I_e	10 A	10 A
J_e	500 A/cm ²	500 A/cm ²
t_{confinement}	35 ms	35 ms
L_{trap}	0.7 m	1.5 m
Capacity	0.51 x 10 ¹²	1.1 x 10 ¹²
% extracted ions	> 75%	50%
% in desired Q	20%	20%
Extracted charge	> 55 nC	85 nC
Ions/pulse	> 1.5 10 ⁹ (Au ³²⁺)	3.3 x 10 ⁹ (Au ³²⁺)
Pulse width	10-20 μs	10-40 μs

Summary

- **With EBTS, more than an order of magnitude improvement in EBIS performance has been achieved.**
- **The RHIC EBIS design will be very similar to the present EBIS operating at BNL.**
- **No significant improvement in performance is required, other than the straightforward scaling of ion output with an increase in trap length. Operation at the required duty factor will be made possible by introduction of an electron collector capable of higher average power dissipation.**
- **Beyond this, changes to the Test EBIS design, which was a device built to demonstrate feasibility, will make the RHIC EBIS an “operational” device, i.e. simpler to maintain, and more reliable due to increased engineering margins on components.**